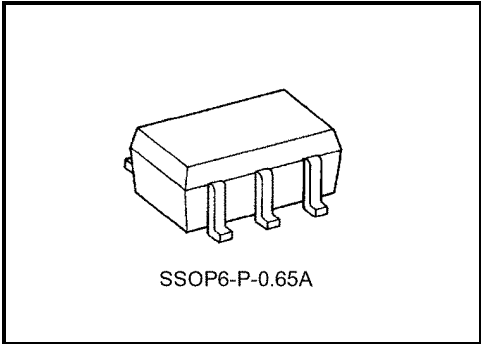


TC7PA34FU

Dual Non-Invert Buffer with 3.6 V Tolerant Input and Output

Features

- Operating voltage range: $V_{CC} = 1.8\sim 3.6\text{ V}$
- High-speed operation: $t_{pd} = 3.5\text{ ns (max)}$ at $V_{CC} = 3.0\sim 3.6\text{ V}$
 $t_{pd} = 4.2\text{ ns (max)}$ at $V_{CC} = 2.3\sim 2.7\text{ V}$
 $t_{pd} = 8.4\text{ ns (max)}$ at $V_{CC} = 1.8\text{ V}$
- High-level output current:
 $I_{OH}/I_{OL} = \pm 24\text{ mA (min)}$ at $V_{CC} = 3.0\text{ V}$
 $I_{OH}/I_{OL} = \pm 18\text{ mA (min)}$ at $V_{CC} = 2.3\text{ V}$
 $I_{OH}/I_{OL} = \pm 6\text{ mA (min)}$ at $V_{CC} = 1.8\text{ V}$
- High latch-up immunity: $\pm 300\text{ mA}$
- High ESD: Higher than or equal to $\pm 200\text{ V (JEITA)}$
Higher than or equal to $\pm 2000\text{ V (MIL)}$
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs



Weight: 0.0068 g (typ.)

Maximum Ratings (Ta = 25°C)

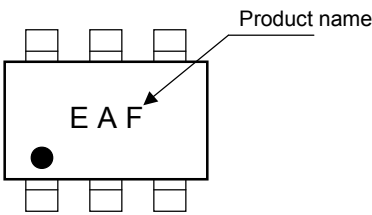
Characteristics	Symbol	Value	Unit
Power supply voltage	V_{CC}	$-0.5\sim 4.6$	V
DC input voltage	V_{IN}	$-0.5\sim 4.6$	V
DC output voltage	V_{OUT}	$-0.5\sim 4.6$ (Note 1)	V
		$-0.5\sim V_{CC} + 0.5$ (Note 2)	
Input diode current	I_{IK}	-50	mA
Output diode current	I_{OK}	± 50 (Note 3)	mA
DC output current	I_{OUT}	$+50$	mA
Power dissipation	P_D	200	mW
DC V_{CC} /ground current	I_{CC}	± 100	mA
Storage temperature	T_{stg}	$-65\sim 150$	°C

Note 1: $V_{CC} = 0\text{ V}$

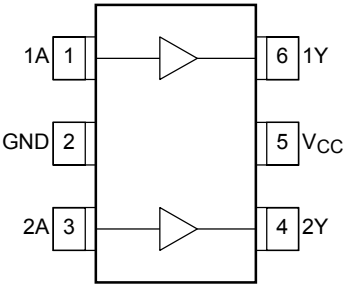
Note 2: High or Low state. The I_{OUT} maximum rating must be adhere to.

Note 3: $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

Marking



Pin Assignment (top view)



Truth Table

A	Y
L	L
H	H

IEC Logic Symbol



Recommended Operating Conditions

Characteristics	Symbol	Value	Unit
Power supply voltage	V _{CC}	1.8~3.6	V
		1.2~3.6 (Note 4)	
Input voltage	V _{IN}	−0.3~3.6	V
Output voltage	V _{OUT}	0~3.6 (Note 5)	V
		0~V _{CC} (Note 6)	
Output Current	I _{OH} /I _{OL}	±24 (Note 7)	mA
		±18 (Note 8)	
		±6 (Note 9)	
Operating temperature	T _{opr}	−40~85	°C
Input rise and fall time	d _I /d _V	0~10 (Note 10)	ns/V

- Note 4: Data retention only
- Note 5: V_{CC} = 0 V
- Note 6: High or Low state
- Note 7: V_{CC} = 3.0~3.6 V
- Note 8: V_{CC} = 2.3~2.7 V
- Note 9: V_{CC} = 1.8 V
- Note 10: V_{IN} = 0.8~2.0 V, V_{CC} = 3.0 V

DC Electrical Characteristics ($T_a = -40 \sim 85^\circ\text{C}$, $2.7\text{ V} < V_{CC} \leq 3.6\text{ V}$)

Characteristics	Symbol	Test Condition		Min	Max	Unit
High-Level Input Voltage	V_{IH}	—	$V_{CC} (V)$ 2.7~3.6	2.0	—	V
Low-Level Input Voltage	V_{IL}	—	2.7~3.6	—	0.8	
High-Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$	$I_{OH} = -100\text{ }\mu\text{A}$	2.7~3.6	$V_{CC} - 0.2$	V
			$I_{OH} = -12\text{ mA}$	2.7	2.2	
			$I_{OH} = -18\text{ mA}$	3.0	2.4	
			$I_{OH} = -24\text{ mA}$	3.0	2.2	
Low-Level Output Voltage	V_{OL}	$V_{IN} = V_{IL}$	$I_{OL} = 100\text{ }\mu\text{A}$	2.7~3.6	—	V
			$I_{OL} = 12\text{ mA}$	2.7	—	
			$I_{OL} = 18\text{ mA}$	3.0	—	
			$I_{OL} = 24\text{ mA}$	3.0	—	
Input Leakage Current	I_{IN}	$V_{IN} = 0 \sim 3.6\text{ V}$	2.7~3.6	—	± 5.0	μA
Power-off Leakage Current	I_{OFF}	$V_{IN}, V_{OUT} = 0 \sim 3.6\text{ V}$	0	—	10.0	μA
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND	2.7~3.6	—	20.0	μA
		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6\text{ V}$	2.7~3.6	—	± 20.0	
Increase in I_{CC} per Input	ΔI_{CC}	$V_{IH} = V_{CC} - 0.6\text{ V}$	2.7~3.6	—	750	

DC Characteristics ($T_a = -40 \sim 85^\circ\text{C}$, $2.3\text{ V} \leq V_{CC} \leq 2.7\text{ V}$)

Characteristics	Symbol	Test Condition		Min	Max	Unit
High-Level Input Voltage	V_{IH}	—	$V_{CC} (V)$ 2.3~2.7	1.6	—	V
Low-Level Input Voltage	V_{IL}	—	2.3~2.7	—	0.7	
High-Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$	$I_{OH} = -100\text{ }\mu\text{A}$	2.3~2.7	$V_{CC} - 0.2$	V
			$I_{OH} = -6\text{ mA}$	2.3	2.0	
			$I_{OH} = -12\text{ mA}$	2.3	1.8	
			$I_{OH} = -18\text{ mA}$	2.3	1.7	
Low-Level Output Voltage	V_{OL}	$V_{IN} = V_{IL}$	$I_{OL} = 100\text{ }\mu\text{A}$	2.3~2.7	—	V
			$I_{OL} = 12\text{ mA}$	2.3	—	
			$I_{OL} = 18\text{ mA}$	2.3	—	
Input Leakage Current	I_{IN}	$V_{IN} = 0 \sim 3.6\text{ V}$	2.3~2.7	—	± 5.0	μA
Power-off Leakage Current	I_{OFF}	$V_{IN}, V_{OUT} = 0 \sim 3.6\text{ V}$	0	—	10.0	μA
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND	2.3~2.7	—	20.0	μA
		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6\text{ V}$	2.3~2.7	—	± 20.0	

DC Characteristics ($T_a = -40 \sim 85^\circ\text{C}$, $1.8\text{ V} \leq V_{CC} < 2.3\text{ V}$)

Characteristics	Symbol	Test Condition		Min	Max	Unit
High-Level Input Voltage	V_{IH}	—	$V_{CC} (V)$ 1.8~2.3	$0.7 \times V_{CC}$	—	V
Low-Level Input Voltage	V_{IL}	—	1.8~2.3	—	$0.2 \times V_{CC}$	
High-Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$	$I_{OH} = -100\text{ }\mu\text{A}$	1.8	$V_{CC} - 0.2$	V
			$I_{OH} = -6\text{ mA}$	1.8	1.4	
Low-Level Output Voltage	V_{OL}	$V_{IN} = V_{IL}$	$I_{OL} = 100\text{ }\mu\text{A}$	1.8	—	V
			$I_{OL} = 6\text{ mA}$	1.8	—	
Input Leakage Current	I_{IN}	$V_{IN} = 0 \sim 3.6\text{ V}$	1.8	—	± 5.0	μA
Power-off Leakage Current	I_{OFF}	$V_{IN}, V_{OUT} = 0 \sim 3.6\text{ V}$	0	—	10.0	μA
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC} \text{ or GND}$	1.8	—	20.0	μA
		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6\text{ V}$	1.8	—	± 20.0	

AC Electrical Characteristics ($T_a = -40 \sim 85^\circ\text{C}$, input $t_r = t_f = 2.0\text{ ns}$, $C_L = 30\text{ pF}$, $R_L = 500\text{ }\Omega$)

Characteristics	Symbol	Test Condition	$V_{CC} (V)$	Min	Max	Unit
Propagation delay time	t_{pLH} t_{pHL}	(Figure 1 and 2)	1.8	1.0	8.4	ns
			2.5 ± 0.2	0.8	4.2	
			3.3 ± 0.3	0.6	3.5	

For $C_L = 50\text{ pF}$, add approximately 300 ps to the AC maximum specification.

Dynamic Switching Characteristics (Ta = 25°C, input tr = tf = 2.0 ns, CL = 30 pF)

Characteristics	Symbol	Test Condition	VCC (V)	TYP.	Unit
Quiet Output Maximum Dynamic VOL	VOLP	VIN = 1.8 V, VIL = 0 V (Note 11)	1.8	0.25	ns
		VIN = 2.5 V, VIL = 0 V (Note 11)	2.5	0.6	
		VIN = 3.3 V, VIL = 0 V (Note 11)	3.3	0.8	
Quiet Output Minimum Dynamic VOL	VOLV	VIN = 1.8 V, VIL = 0 V (Note 11)	1.8	-0.25	ns
		VIN = 2.5 V, VIL = 0 V (Note 11)	2.5	-0.6	
		VIN = 3.3 V, VIL = 0 V (Note 11)	3.3	-0.8	
Quiet Output Minimum Dynamic VOH	VOLP	VIN = 1.8 V, VIL = 0 V (Note 11)	1.8	1.5	ns
		VIN = 2.5 V, VIL = 0 V (Note 11)	2.5	1.9	
		VIN = 3.3 V, VIL = 0 V (Note 11)	3.3	2.2	

Note 11: Characteristics guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

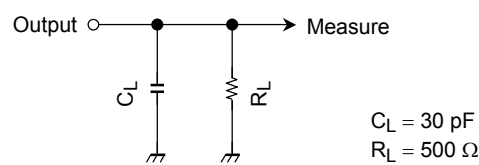
Characteristics	Symbol	Test Condition	VCC (V)	TYP.	Unit
Input Capacitance	CIN	—	1.8, 2.5, 3.3	4	pF
Power Dissipation Capacitance	CPD	fIN = 10 MHz (Note 12)	1.8, 2.5, 3.3	12	pF

Note 12: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

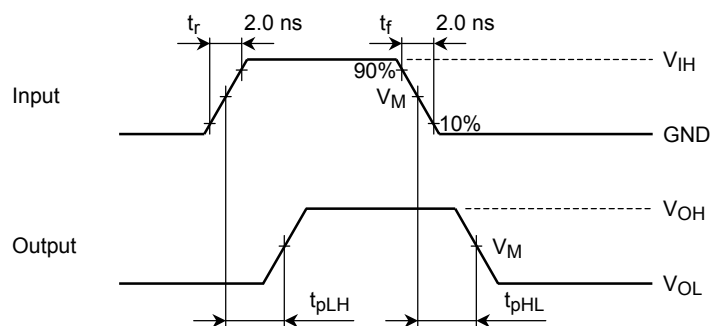
$$I_{CC}(\text{opr.}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2$$

Figure 1 Test Circuit



AC Waveforms

Figure 2 t_{pLH} , t_{pHL}

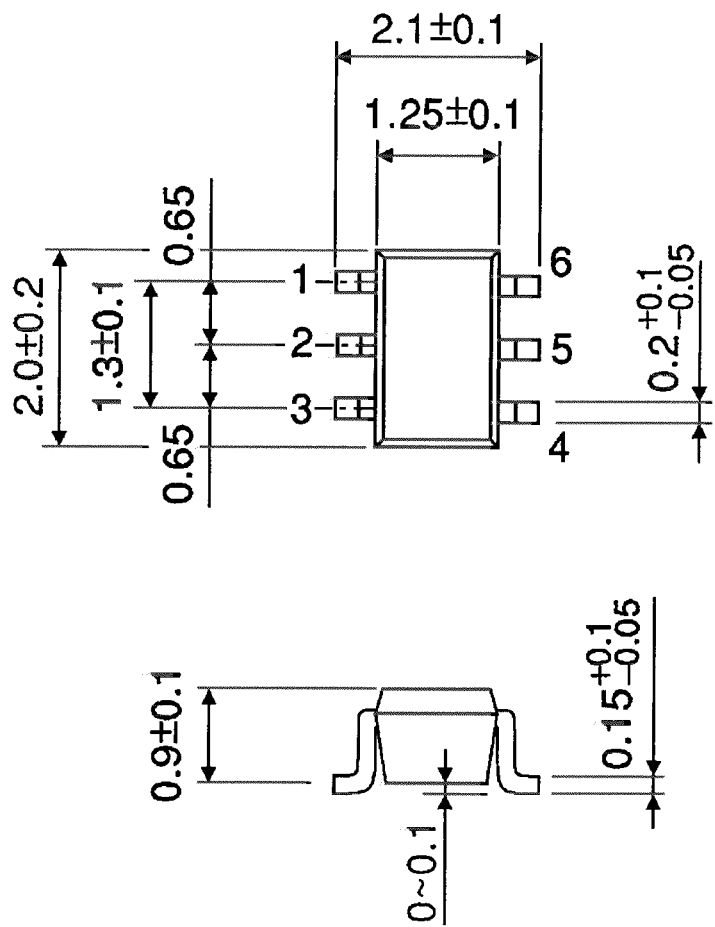


Symbol	V_{CC}		
	$3.3 \pm 0.3 \text{ V}$	$2.5 \pm 0.2 \text{ V}$	1.8 V
V_{IH}	2.7 V	V_{CC}	V_{CC}
V_M	1.5 V	$V_{CC}/2$	$V_{CC}/2$

Package Dimensions

SSOP6-P-0.65A

Unit: mm



Weight: 0.0068 g (typ.)

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000707EBA

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